

### Preliminary

# SIGC223T120R2CS

#### IGBT Chip in NPT-technology

#### **FEATURES:**

- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

#### This chip is used for:

• IGBT Modules

#### Applications:

• drives, SMPS, resonant applications



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC223T120R2CS	1200V	150A	14.4 x 15.5 mm <sup>2</sup>	sawn on foil	tbd

#### **MECHANICAL PARAMETER:**

Raster size	14.4 X 15.5	mm <sup>2</sup>		
Emitter pad size	8x( 3.67x6.77 )			
Gate pad size	1.49 x 1.51			
Area total / active	223.5 / 189.9			
Thickness	175	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	54 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	bond electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month			



## SIGC223T120R2CS

#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	150	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	300	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

### STATIC CHARACTERISTICS (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions		Value			Unit	
i diametei	Cymbol	Conditions	min.	typ.	max.		
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V , I <sub>C</sub> =4mA	1200				
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =150A	2.7	3.2	3.7	V	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I <sub>C</sub> =6mA , V <sub>GE</sub> =V <sub>CE</sub>	4.5	5.5	6.5		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			900	μA	
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =30V			600	nA	
Integrated gate resistor	R <sub>Gint</sub>		1.75	2	3.25	Ω	

#### **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol Conditions		Value			Unit
raiametei	Syllibol	Conditions	min.	typ.	max.	Onn
Input capacitance	Ciss	$V_{CE}=25V$ ,	-	9.3		nF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	1.4		
Reverse transfer capacitance	Crss	f=1MHz	-	0.7		

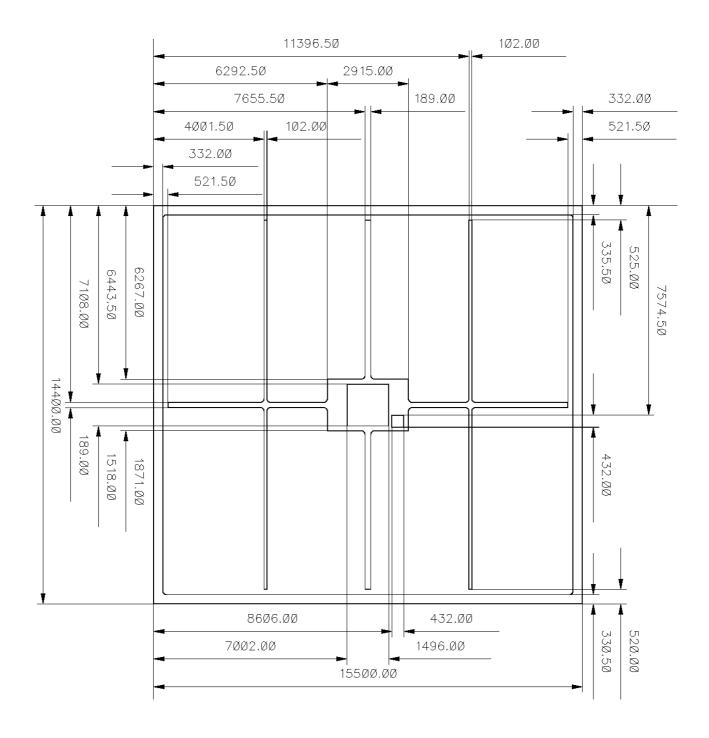
#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
- and annexed	Symbol	Conditions	min.	typ.	max.	Ullit
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C	-	125		ns
Rise time	$t_{\rm r}$	V <sub>CC</sub> =600V,	-	100		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =150A, V <sub>GE</sub> =-15/15V,	-	590		
Fall time	$t_{\mathrm{f}}$	$R_{\rm G}$ =6.8 $\Omega$	-	70		



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#### **CHIP DRAWING:**





#### **Preliminary**

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FURTHER ELECTRICAL CHARACTERISTICS:					
This chip data sheet refers to the device data sheet	tbd				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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